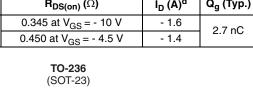




Vishay Siliconix

P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^d	Q _g (Typ.)		
- 60	0.345 at V _{GS} = - 10 V	- 1.6	2.7 nC		
	0.450 at V _{GS} = - 4.5 V	- 1.4	2.7 110		



D

Top View Si2309CDS (N9)*

* Marking Code

Ordering Information: Si2309CDS-T1-E3 (Lead (Pb)-free)

Si2309CDS-T1-GE3 (Lead (Pb)-free and Halogen-free)

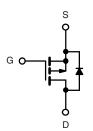
FEATURES

- Halogen-free Option Available
- TrenchFET® Power MOSFET



APPLICATIONS

· Load Switch



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25 ^{\circ}C$, unless Parameter		Symbol	Limit	Uni	
Drain-Source Voltage		V _{DS}	- 60	V	
Gate-Source Voltage		V _{GS}	GS ± 20		
	T _C = 25 °C		- 1.6		
0 11 0 1 0 1 7 1 1 2 2 2 3 h	T _C = 70 °C		- 1.3		
Continuous Drain Current $(T_J = 150 {}^{\circ}C)^{a, b}$	T _A = 25 °C	I _D	- 1.2 ^{a, b}		
	T _A = 70 °C		- 1.0 ^{a, b}		
Pulsed Drain Current (10 μs Pulse Width)		I _{DM}	- 8	A	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 5		
	T _C = 25 °C	1	- 1.4		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 0.9 ^{a, b}		
	T _C = 25 °C		1.7		
	T _C = 70 °C	В	1.1	10/	
Maximum Power Dissipation	T _A = 25 °C	P _D	1.0 ^{a, b}	W	
	T _A = 70 °C		0.67 ^{a, b}		
Operating Junction and Storage Temperature Rar	T _J , T _{stg}	- 55 to 150	90		
Soldering Recommendations (Peak Temperature)		260	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 5 s	R _{thJA}	92	120	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	58	73] 0/**	

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. t = 5 s.
- c. Maximum under Steady State conditions is 166 °C/W.
- d. When T_C = 25 °C.

Si2309CDS

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 65		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	Ι _D = - 230 μΑ		4.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			- 100	nA	
Zovo Coto Voltogo Dunio Comunit	I _{DSS}	V _{DS} = - 60 V, V _{GS} = 0 V			- 1	,	
Zero Gate Voltage Drain Current		V _{DS} = - 60 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = -10 \text{ V}$	- 6			Α	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 1.25 A		0.285	0.345	Ω	
		V _{GS} = - 4.5 V, I _D = - 1.0 A		0.360	0.450		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 1.0 A		2.8		S	
Dynamic ^b	1			I	L		
Input Capacitance	C _{iss}			210		pF	
Output Capacitance	C _{oss}	V _{DS} = - 30 V, V _{GS} = 0 V, f = 1 MHz		28			
Reverse Transfer Capacitance	C _{rss}			20			
Total Gate Charge	Qg			2.7	4.1	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.25 \text{ A}$		0.8			
Gate-Drain Charge	Q_{gd}			1.2			
Gate Resistance	R_{g}	f = 1 MHz		7		Ω	
Turn-On Delay Time	t _{d(on)}			40	60		
Rise Time	t _r	V_{DD} = - 30 V, R_L = 30 Ω		35	55	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1 \text{ A, } V_{GEN} = -4.5 \text{ V, } R_g = 1 \Omega$		15	25		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			5	10		
Rise Time	t _r	V_{DD} = - 30 V, R_L = 30 Ω		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 1 A, V_{GEN} = - 10 V, R_g = 1 Ω		15	25		
Fall Time	t _f			10	20		
Drain-Source Body Diode Characteris	tics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 1.4	Α	
Pulse Diode Forward Current	I _{SM}				- 8	^	
Body Diode Voltage	V_{SD}	I _S = - 0.75 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time t _{rr}				30	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	- I _F = - 1.25 A, dl/dt = 100 A/μs, T _J = 25 °C		33	60	nC	
Reverse Recovery Fall Time	t _a	η - 1.20 Λ, αι/αι - 100 Λ/μο, 1 J - 20 0		18		ns	
Reverse Recovery Rise Time	t _b	[12			

Notes:

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

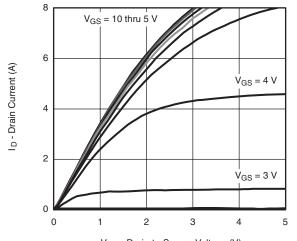
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

2.0

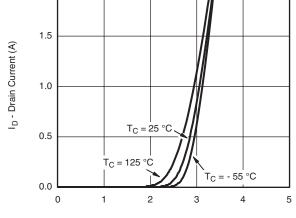


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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

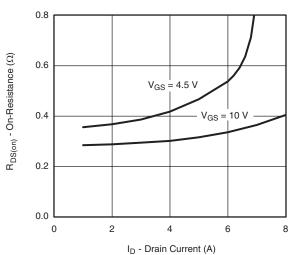


 $V_{\mbox{\scriptsize DS}}$ - Drain-to-Source Voltage (V)

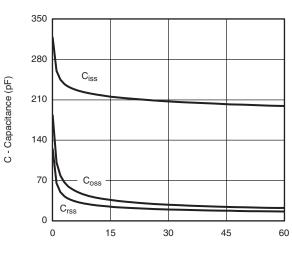


V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**

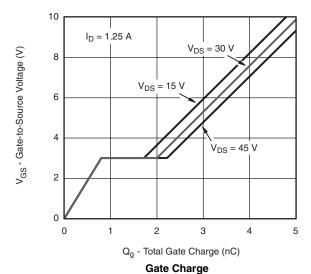


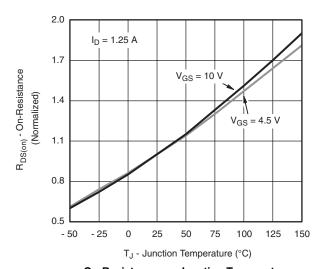


On-Resistance vs. Drain Current and Gate Voltage



V_{DS} - Drain-to-Source Voltage (V) **Capacitance**



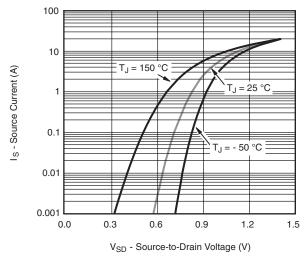


On-Resistance vs. Junction Temperature

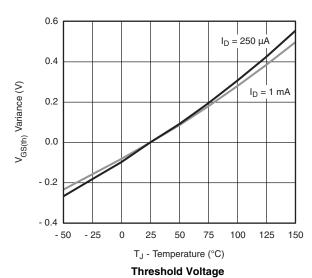
Si2309CDS

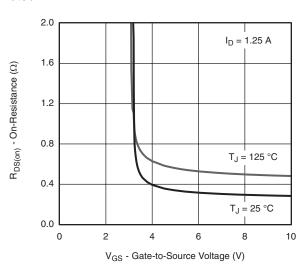
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

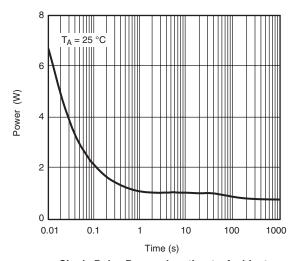


Source-Drain Diode Forward Voltage

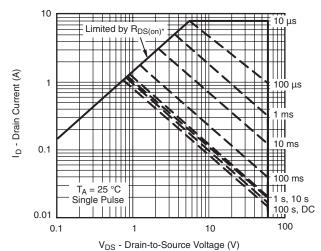




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



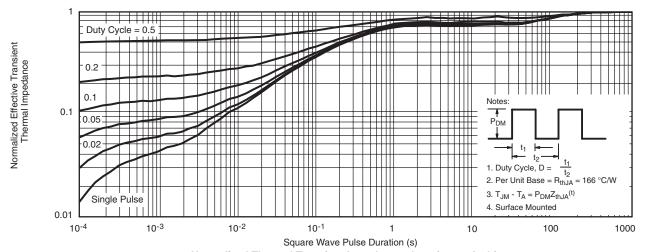
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

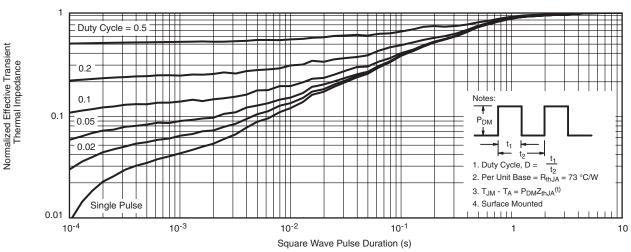


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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com